

**Features**

- Uses CRM(CQ) advanced SkyMOS4 technology
- Extremely low on-resistance  $R_{DS(on)}$
- Excellent  $Q_g \times R_{DS(on)}$  product(FOM)
- AEC-Q101 Qualified

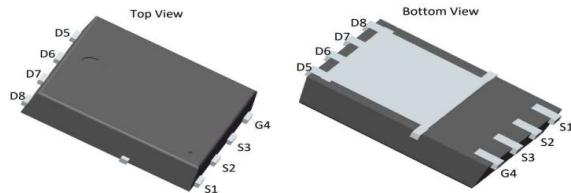
**Product Summary**

$V_{DS}$	100V
$R_{DS(on).typ}$	17.5mΩ
$I_D$	30A

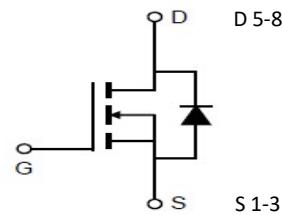
**Applications**

- DCDC Converter
- Switching applications
- UPS (Uninterruptible Power Supplies)

**100% DVDS Tested  
100% Avalanche Tested**



CRSM220N10N4Q

**Package Marking and Ordering Information**

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRSM220N10N4Q	220N10N4Q	PDFN5x6	Tape&reel	N/A	N/A	4000pcs

**Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit
Drain-source voltage	$V_{DS}$	100	V
Continuous drain current	$I_D$	30	A
$T_C = 25^\circ\text{C}$ (Silicon limit)		21	
$T_C = 100^\circ\text{C}$ (Silicon limit)			
Pulsed drain current ( $T_C = 25^\circ\text{C}$ , $t_p$ limited by $T_{jmax}$ )	$I_D$ pulse	120	A
Avalanche energy, single pulse ( $I_{AS} = 9\text{A}$ , $R_g=50\Omega$ ) <sup>[1]</sup>	$E_{AS}$	12	mJ
Gate-Source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation ( $T_C = 25^\circ\text{C}$ )	$P_{tot}$	38	W
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55...+175	°C
Soldering temperature, wave soldering only allowed at leads (1.6mm from case for 10s)	$T_{sold}$	260	°C

※. Notes:

EAS is tested at starting  $T_j = 25^\circ\text{C}$ ,  $L = 0.3\text{mH}$ ,  $I_{AS} = 9\text{A}$ ,  $V_{GS} = 10\text{V}$ .

**Thermal Resistance**

Parameter	Symbol	Max	Unit
Thermal resistance, junction – case (junction-heat spreader)	R <sub>thJC</sub>	3.9	°C/W
Thermal resistance, junction – ambient(min. footprint)	R <sub>thJA</sub>	52	

**Electrical Characteristic (at T<sub>j</sub> = 25 °C, unless otherwise specified)**

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

**Static Characteristic**

Drain-source breakdown voltage	BV <sub>DSS</sub>	100	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA
		100	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =1mA
Gate threshold voltage	V <sub>GS(th)</sub>	1.2	1.6	2.1	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA
Zero gate voltage drain current	I <sub>DSS</sub>	-	-	1 100	μA	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V T <sub>j</sub> =25°C T <sub>j</sub> =125°C
Gate-source leakage current	I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	17.5	22.0	mΩ	V <sub>GS</sub> =10V, ID=15A T <sub>j</sub> =25°C
			20.0	25.0	mΩ	V <sub>GS</sub> =5V, ID=15A T <sub>j</sub> =25°C
Transconductance	g <sub>f</sub>	-	40	-	S	V <sub>DS</sub> =5V, ID=15A

**Dynamic Characteristic**

Input Capacitance	C <sub>iss</sub>	-	815	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =50V, f=1MHz
Output Capacitance	C <sub>oss</sub>	-	137	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	-	7	-		
Gate Total Charge	Q <sub>G</sub>	-	16	-	nC	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =15A,,f=1MHz
Gate-Source charge	Q <sub>gs</sub>	-	4	-		
Gate-Drain charge	Q <sub>gd</sub>	-	3	-		
Turn-on delay time	t <sub>d(on)</sub>	-	5	-		
Rise time	t <sub>r</sub>	-	28	-		
Turn-off delay time	t <sub>d(off)</sub>	-	15	-	ns	V <sub>GS</sub> =10V, V <sub>DD</sub> =50V, R <sub>G_ext</sub> =3Ω, ID=15A
Fall time	t <sub>f</sub>	-	8	-		
Gate resistance	R <sub>G</sub>	-	0.8	-	Ω	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz



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CRSM220N10N4Q

SkyMOS4 N-MOSFET 100V, 17.5mΩ, 30A

**Body Diode Characteristic**

<b>Parameter</b>	<b>Symbol</b>	<b>Value</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		
Diode continuous forward current	I <sub>s</sub>	-	-	30	A	T <sub>c</sub> = 25°C
Diode pulse current	I <sub>s</sub> pulse	-	-	120	A	T <sub>c</sub> = 25°C
Body Diode Forward Voltage	V <sub>SD</sub>	-	0.9	1.4	V	V <sub>GS</sub> =0V, I <sub>SD</sub> =15A
Body Diode Reverse Recovery Time	t <sub>rr</sub>	-	40	-	ns	V <sub>DS</sub> =25V, I <sub>F</sub> =15A, dI/dt=100A/ μs
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	-	40	-	nC	

## Typical Performance Characteristics

Fig 1: Output Characteristics

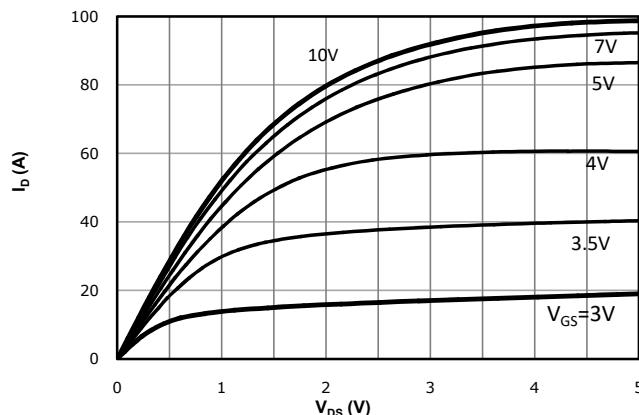


Fig 2: Transfer Characteristics

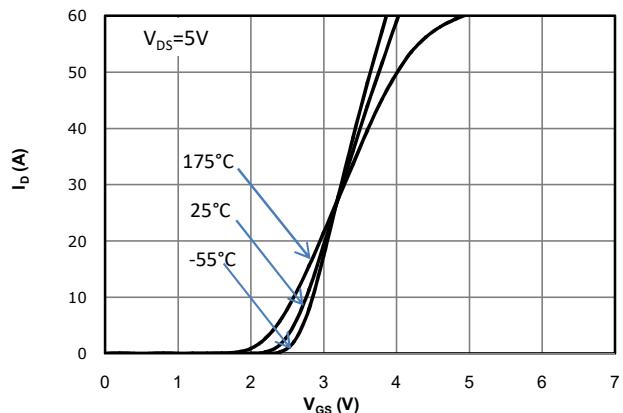
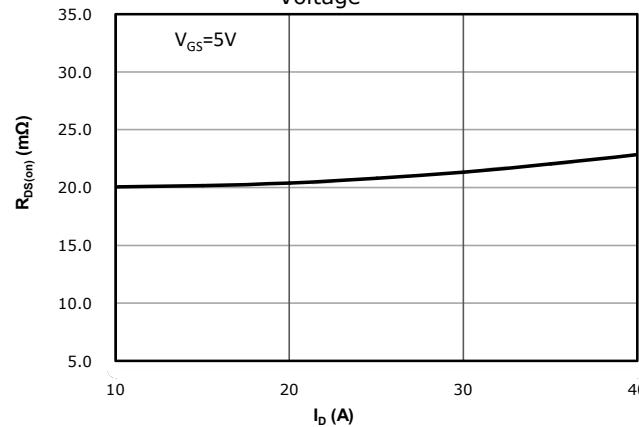
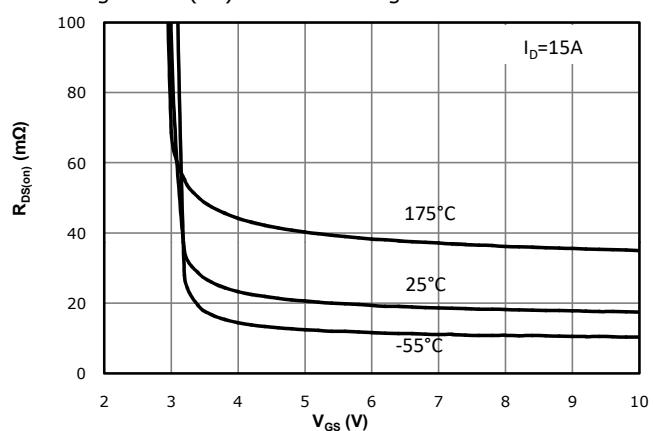
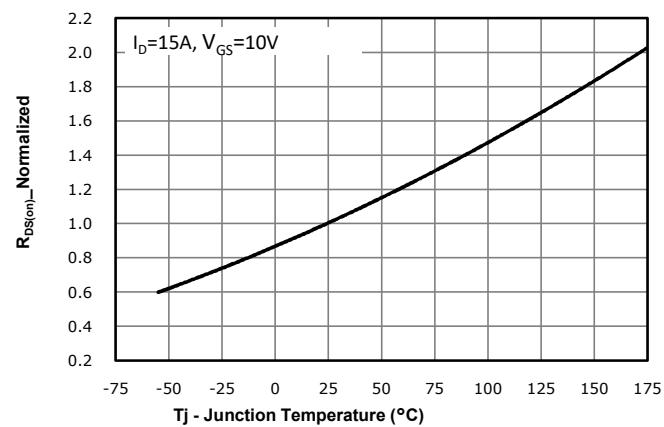
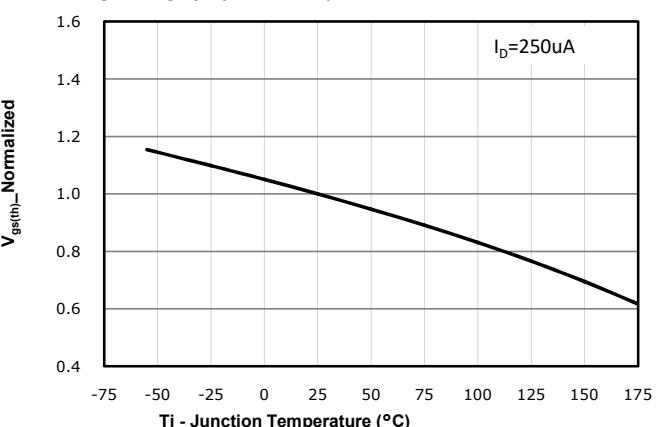
Fig 3: R<sub>d(on)</sub> vs Drain Current and Gate VoltageFig 4: R<sub>d(on)</sub> vs Gate VoltageFig 5: R<sub>d(on)</sub> vs. TemperatureFig 6: V<sub>gs(th)</sub> vs. Temperature

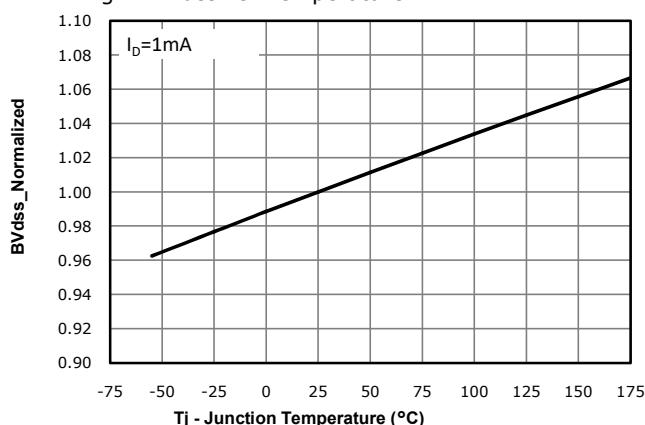
Fig 7: BV<sub>dss</sub> vs. Temperature


Fig 8: Capacitance Characteristics

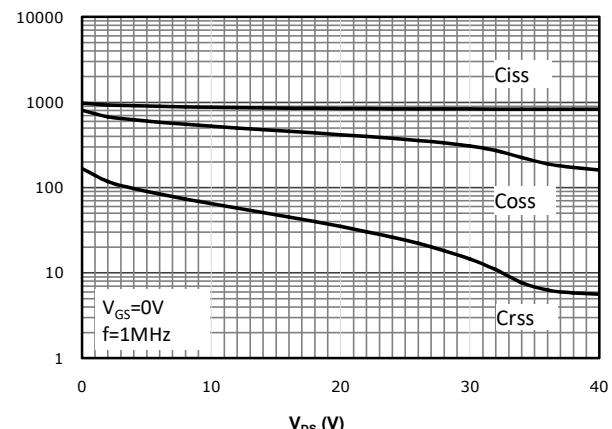


Fig 9: Gate Charge Characteristics

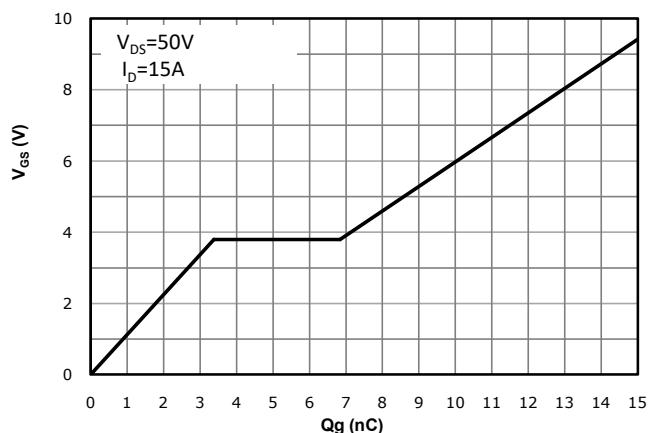


Fig 10: Body-diode Forward Characteristics

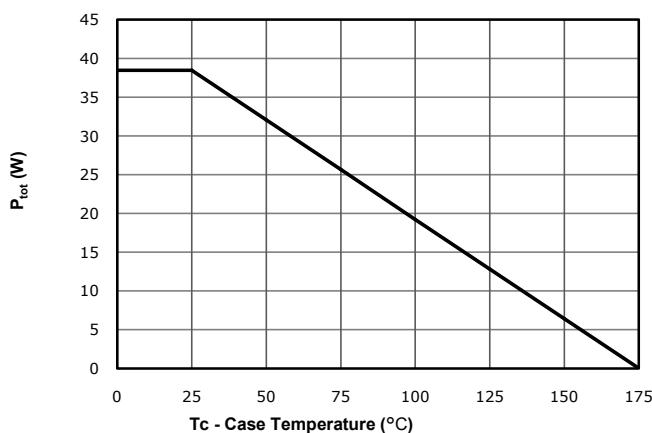
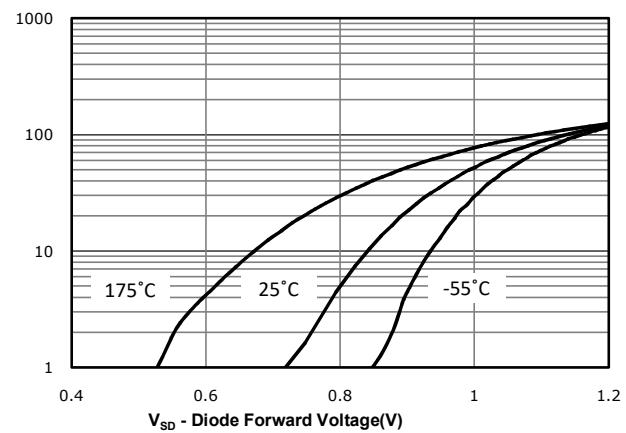


Fig 11: Power Dissipation

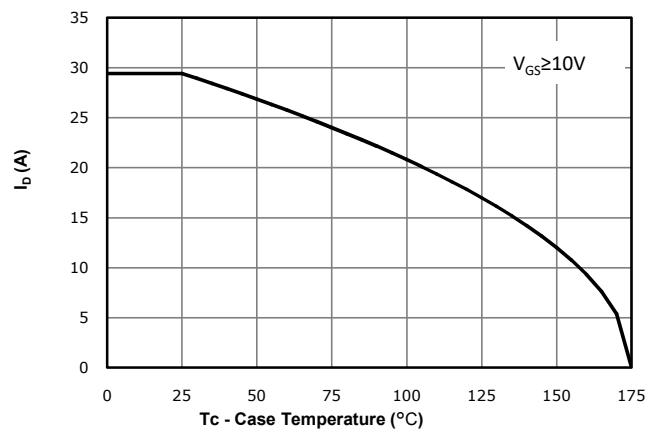


Fig 13: Safe Operating Area

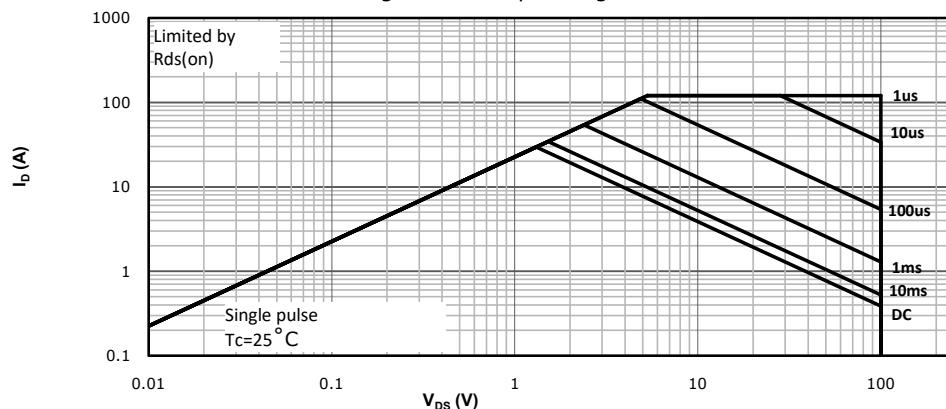
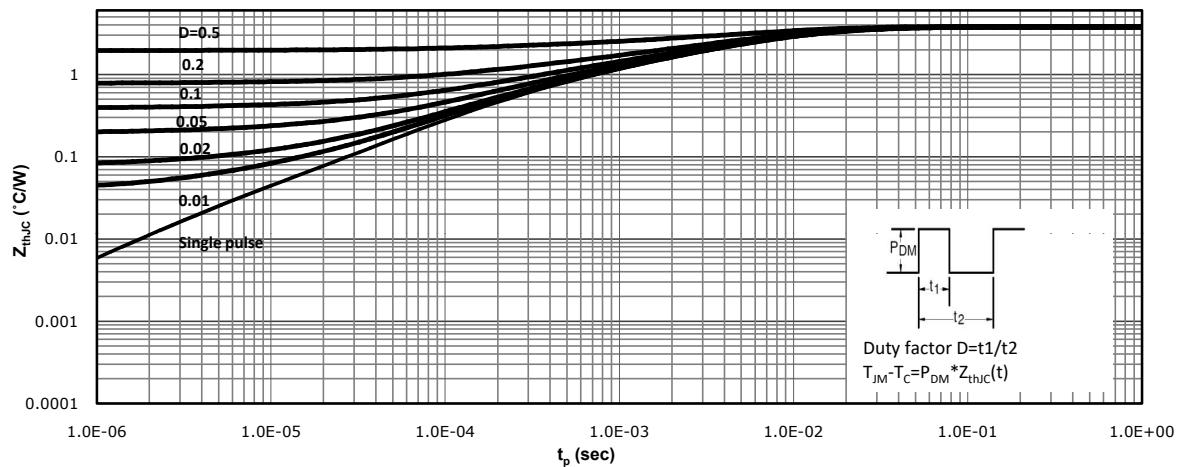
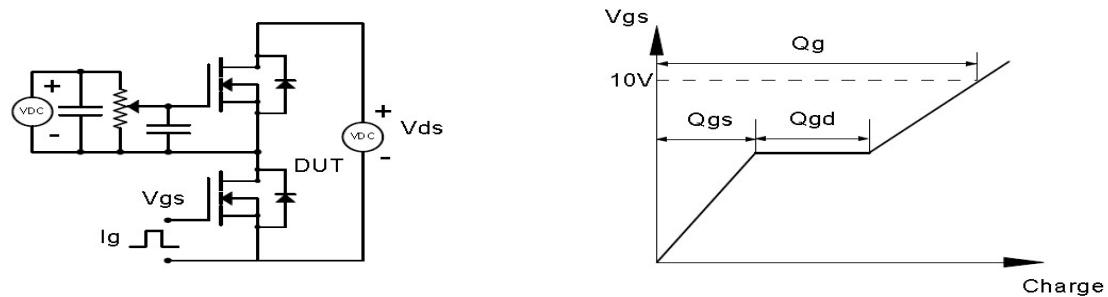


Fig 14: Max. Transient Thermal Impedance

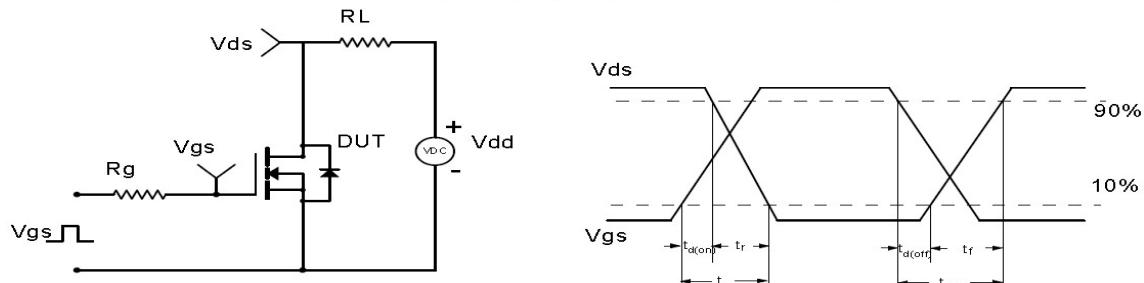


## Test Circuit & Waveform

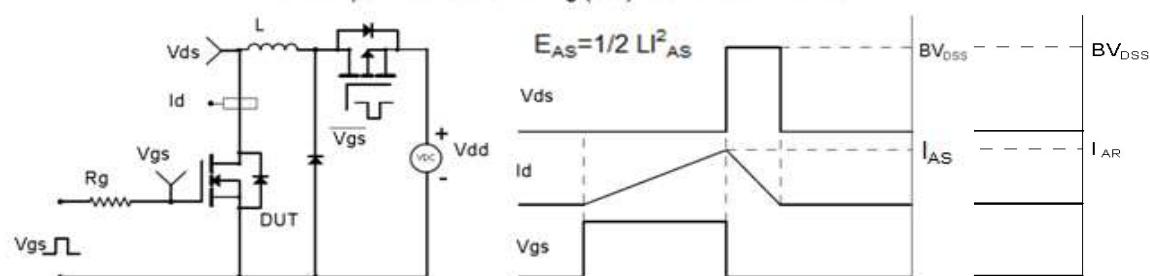
Gate Charge Test Circuit & Waveform



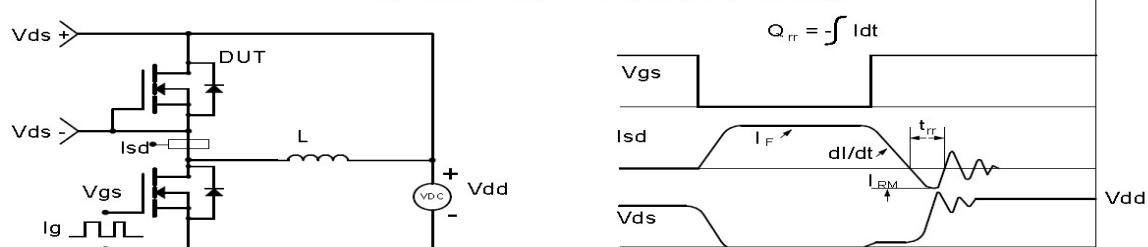
Resistive Switching Test Circuit & Waveforms

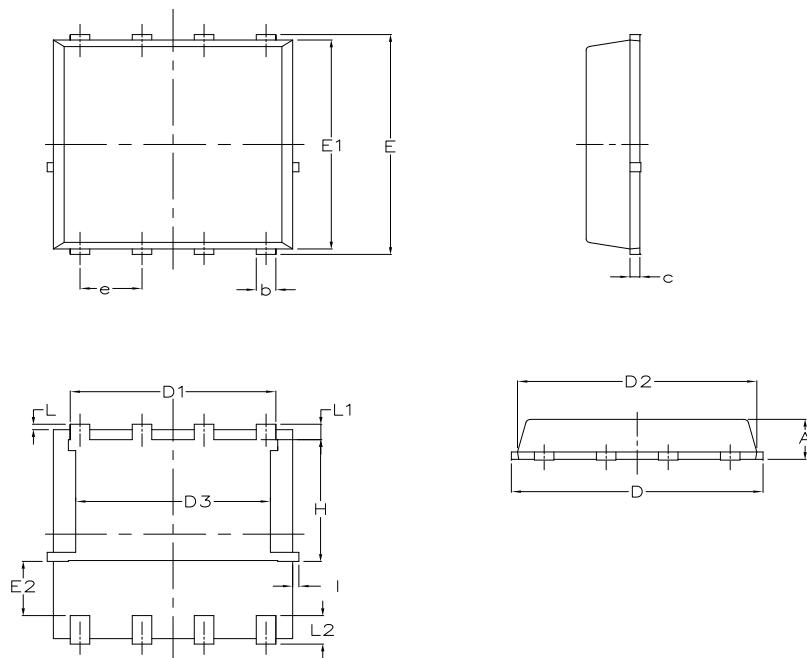


Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



**Package Outline: PDFN5x6 Type P**


Symbol	Dimensions In Millimeters			Dimensions In Inches		
	Min.	NOM.	Max.	Min.	NOM.	Max.
A	0.90	1.10	1.20	0.035	0.043	0.047
b	0.31	0.41	0.51	0.012	0.016	0.020
c	0.15	0.20	0.30	0.006	0.008	0.012
D	4.80	4.98	5.15	0.189	0.196	0.203
D1	3.91	4.22	4.36	0.154	0.166	0.172
D2	4.80	4.90	5.00	0.189	0.193	0.197
D3	3.85	4.00	4.15	0.152	0.157	0.163
E	5.90	6.05	6.15	0.232	0.238	0.242
E1	5.65	5.76	5.85	0.222	0.227	0.230
E2	1.10	-	-	0.043	-	-
e	1.27 BSC			0.050 BSC		
L	0.05	0.15	0.25	0.002	0.006	0.010
L1	0.38	0.43	0.50	0.015	0.017	0.020
L2	0.51	0.79	0.86	0.020	0.031	0.034
H	3.25	3.35	3.58	0.128	0.132	0.141
I	0.00	-	0.18	0.000	-	0.007

**Marking**

## NOTE:

XAAAAAAA

X —Assembly location code

AAAAAAA —Assembly lot NO. last 7 digits

Y —Bin code



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## Revision History

Revision	Date	Major changes
1.0	2024/7/3	Release of preliminary version.
1.1	2025/3/17	<ul style="list-style-type: none"><li>1.Update package name.</li><li>2.Delete 25°C Package limit.</li><li>3.Update Fig2/5/6/7.</li><li>4.Delete Dynamic Characteristic parameters spec.</li></ul>

## Disclaimer

CRM reserves the right to change any product or information in this Specification at any time without prior notice.

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The product is not intended for use in applications that require extraordinary levels of quality and reliability, such as aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.



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